

Notice of References Cited	Application/Control No. 10/064,265	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Cheukfan Lee	Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,801,254	10-2004	Nishio, Kenichi	348/241
*	B	US-6,002,508	12-1999	Mai, Che-Kuei	359/212
*	C	US-6,084,691	07-2000	Tsai et al.	358/474
*	D	US-5,627,603	05-1997	Sakai, Shinji	348/708
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003110798 A	04-2003	Japan	MIYASHITA, MIKIAKI	H04N 01/028
	O	JP 2002218185 A	08-2002	Japan	WADA, SHINICHIRO	H04N 01/19
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.